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	Application Number	
	Filing Date	
	First Named Inventor	Olgica Bakajin et al
	Group Art Unit	
	Examiner Name	
Sheet	1	of 1
	Attorney Docket Number	II -11046

## U.S. PATENT DOCUMENTS

## FOREIGN PATENT DOCUMENTS

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#### OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
		BENJAMIN MESSER et al	Microchannel Networks for Nanowire Patterning	J. Am. Chem. Soc. 2000/22, 10232-10333
		X.Y. ZHANG et al	Template synthesis of High-Density Carbon Nanotube Arrays	Journal of Crystal Growth 233 (2001) 306-310
VM		JIAN CHEN et al	Room-Temperature Assembly of Directional Carbon Nanotube Strings	J. Am. Chem. Soc. Vol. 124, No. 5 2002 pgs. 758-759
		Y.C. SUI et al	Synthesis of Multi Branched Carbon Nanotubes in Porous Anodic Aluminum Oxide Template	Carbon 39 (2001) 1709-1715
		JIAN CHEN et al	Room-Temperature Assembly of Directional Carbon Nanotube Strings	Advanced Technologies Group, Zyxex Corporation
		TAKASHI, KYOTANI ET AL	Synthesis of carbon nanotube composites in nanochannels of an anodic aluminum oxide film	Inst. Chem. Reaction Sci., Tohoku University, Japan Bulletin of the Chem. Soc. Of Japan (1999) 72,(9), 1957-1970
		TAKASHI, KYOTANI	Preparation of Ultrafine Carbon Tubes in Nanochannels of an Anodic Aluminum Oxide Film	Chem. Mater., 1996, 8, 2109-2113
		J.LI, C. PAPADOPOULOS ET AL	Highly-ordered Nanotube Arrays for Electronics applications	Applied Physics Letters vol. 75 Number 3 July 19, 1999

Examiner Signature	<i>skl/Mem</i>	Date Considered	4/11/05
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